SHIGA7.021APC PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant

Sato et al.

Appl. No.

: 10/540,056

Filed

: June 22, 2005

For

: POSITIVE RESIST COMPOSITION

AND METHOD OF FORMING

RESIST PATTERN

Examiner

: Chu, John S.Y.

Group Art Unit : 1795

AMENDMENT AND RESPONSE TO OFFICE ACTION

Mail Stop Amendment

Commissioner for Patents

P.O. Box 1450 Alexandria, VA 22313-1450

Alexandria, VA 22313-145

Dear Sir:

In response to the Office Action mailed March 9, 2009, please consider the following amendments and remarks.

Amendments to the claims are reflected in the listing of claims which begins on page 2 of this paper.

Summary of Interview begins on page 4 of this paper.

Remarks begin on page 5 of this paper.